

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
			Examiner Scott B. Geyer	Art Unit 2829	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US- 5795797	08-1998	chester et al.	—
*	B	US- 5518956	05-1996	LIU et al.	—
*	C	US- 5429994	07-1995	ISHIKAWA	—
	D	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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